

# FDMS2D4N03S

# N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30 V, 163 A, 1.8 m $\Omega$

#### **Features**

- Max  $r_{DS(on)}$  = 1.8 m $\Omega$  at  $V_{GS}$  = 10 V,  $I_D$  = 28 A
- Max  $r_{DS(on)}$  = 2.34 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 26 A
- High Performance Technology for Extremely Low r<sub>DS(on)</sub>
- SyncFET<sup>TM</sup> Schottky Body Diode
- 100% UIL Tested
- RoHS Compliant

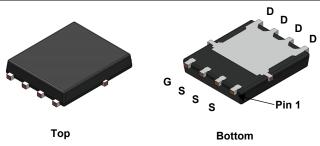
## **General Description**

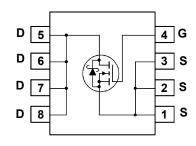
The FDMS2D4N03S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{\text{DS}(\text{on})}$  while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic schottky body diode.

## **Applications**

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU Low Side Switch
- Networking Point of Load Low Side Switch
- Telecom Secondary Side Rectification







Power 56

#### **MOSFET Maximum Ratings** T<sub>A</sub> = 25 °C unless otherwise noted.

| Symbol                            | Parame                                 |                         | Ratings   | Units       |    |
|-----------------------------------|--|-------------------------|-----------|-------------|----|
| $V_{DS}$                          | Drain to Source Voltage                |                         |           | 30          | V  |
| $V_{GS}$                          | Gate to Source Voltage                 |                         |           | ±16         | V  |
|                                   | Drain Current -Continuous              | T <sub>C</sub> = 25 °C  | (Note 5)  | 163         |    |
|                                   | -Continuous                            | T <sub>C</sub> = 100 °C | (Note 5)  | 103         | ^  |
| ID                                | -Continuous                            | T <sub>A</sub> = 25 °C  | (Note 1a) | 28          | Α  |
|                                   | -Pulsed                                |                         | (Note 4)  | 694         |    |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy          |                         | (Note 3)  | 175         | mJ |
| В                                 | Power Dissipation                      | T <sub>C</sub> = 25 °C  |           | 74          | W  |
| $P_{D}$                           | Power Dissipation                      | T <sub>A</sub> = 25 °C  | (Note 1a) | 2.5         | VV |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Tempera | ture Range              |           | -55 to +150 | °C |

#### **Thermal Characteristics**

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case             | 1.7 | °C/W |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a | 50  | C/VV |

#### **Package Marking and Ordering Information**

| Device Marking | Device      | Package  | Reel Size | Tape Width | Quantity   |
|----------------|-------------|----------|-----------|------------|------------|
| FDMS2D4N03S    | FDMS2D4N03S | Power 56 | 13 "      | 12 mm      | 3000 units |

## **Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted.

| Symbol                               | Parameter                                    | Test Conditions                                | Min. | Тур. | Max. | Units |
|--------------------------------------|--|--|------|------|------|-------|
| Off Chara                            | cteristics                                   |  |      |      |      |       |
| BV <sub>DSS</sub>                    | Drain to Source Breakdown Voltage            | I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V   | 30   |      |      | V     |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature<br>Coefficient | I <sub>D</sub> = 10 mA, referenced to 25 °C    |      | 18   |      | mV/°C |
| I <sub>DSS</sub>                     | Zero Gate Voltage Drain Current              | V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V  |      |      | 500  | μΑ    |
| I <sub>GSS</sub>                     | Gate to Source Leakage Current               | V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V |      |      | ±100 | nA    |

#### On Characteristics

| V <sub>GS(th)</sub>                    | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$                          | 1.0 | 1.6 | 3.0  | V     |
|--|--|---|-----|-----|------|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I <sub>D</sub> = 10 mA, referenced to 25 °C                       |     | -4  |      | mV/°C |
| r <sub>DS(on)</sub>                    |  | $V_{GS} = 10 \text{ V}, I_D = 28 \text{ A}$                       |     | 1.4 | 1.8  |       |
|  | Static Drain to Source On Resistance                     | $V_{GS} = 4.5 \text{ V}, I_D = 26 \text{ A}$                      |     | 1.7 | 2.34 | mΩ    |
|  |  | $V_{GS} = 10 \text{ V}, I_D = 28 \text{ A}, T_J = 125 \text{ °C}$ |     | 2.0 | 2.8  |       |
| 9 <sub>FS</sub>                        | Forward Transconductance                                 | V <sub>DS</sub> = 5 V, I <sub>D</sub> = 28 A                      |     | 200 |      | S     |

#### **Dynamic Characteristics**

| C <sub>iss</sub> | Input Capacitance            | \\ -45\\\\ -0\\   |     | 4670 | 6540 | pF |
|------------------|------------------------------|---|-----|------|------|----|
| Coss             | Output Capacitance           | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz |     | 1395 | 1955 | pF |
| C <sub>rss</sub> | Reverse Transfer Capacitance | 1 - 1 WII 12  |     | 63   | 120  | pF |
| R <sub>a</sub>   | Gate Resistance              |   | 0.1 | 0.5  | 1.5  | Ω  |

#### **Switching Characteristics**

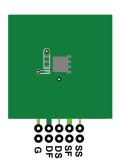
| t <sub>d(on)</sub>  | Turn-On Delay Time            |  | 15  | 28 | ns |
|---------------------|-------------------------------|--|-----|----|----|
| t <sub>r</sub>      | Rise Time                     | V <sub>DD</sub> = 15 V, I <sub>D</sub> = 28 A,                   | 4   | 10 | ns |
| t <sub>d(off)</sub> | Turn-Off Delay Time           | $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$                          | 38  | 61 | ns |
| t <sub>f</sub>      | Fall Time                     |  | 3   | 10 | ns |
| $Q_g$               | Total Gate Charge             | V <sub>GS</sub> = 0 V to 10 V                                    | 63  | 88 | nC |
| $Q_g$               | Total Gate Charge             | $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$ | 28  | 40 | nC |
| Q <sub>gs</sub>     | Gate to Source Charge         | I <sub>D</sub> = 28 A  | 9.8 |    | nC |
| Q <sub>gd</sub>     | Gate to Drain "Miller" Charge |  | 4.9 |    | nC |

#### **Drain-Source Diode Characteristics**

| $V_{SD}$        | Source to Drain Diode Forward Voltage   | $V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$ (Note 2) | 0.65 | 1.2 | V   |
|-----------------|---|--|------|-----|-----|
|                 | Source to Drain blode 1 of ward voltage | $V_{GS} = 0 \text{ V}, I_S = 28 \text{ A}$ (Note 2)    | 0.78 | 1.3 | · ' |
| t <sub>rr</sub> | Reverse Recovery Time                   | I <sub>E</sub> = 28 A, di/dt = 300 A/μs                | 37   | 59  | ns  |
| $Q_{rr}$        | Reverse Recovery Charge                 | 1 <sub>F</sub> - 20 A, αι/αι - 300 A/μS                | 51   | 81  | nC  |

#### Notes:

<sup>1.</sup> R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0CA</sub> is determined by the user's board design.



50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
  3. E<sub>AS</sub> of 175 mJ is based on starting T<sub>J</sub> = 25 °C; N-ch: L = 3 mH, I<sub>AS</sub> = 10.8 A, V<sub>DD</sub> = 30 V, V<sub>GS</sub> =10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 33 A.
  4. Pulsed Id please refer to Fig 11 SOA graph for more details.
  5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

### Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted.

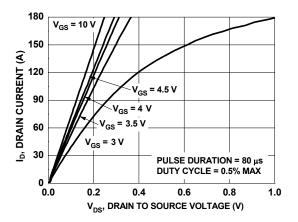


Figure 1. On Region Characteristics

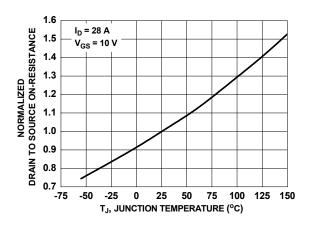


Figure 3. Normalized On Resistance vs. Junction Temperature

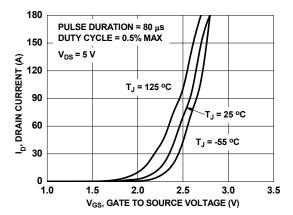


Figure 5. Transfer Characteristics

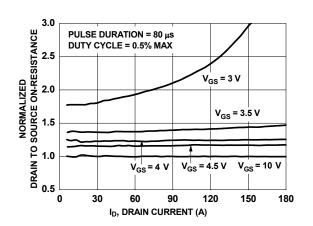


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

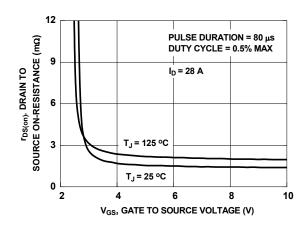


Figure 4. On-Resistance vs. Gate to Source Voltage

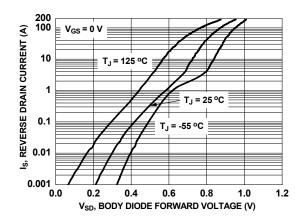


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted.

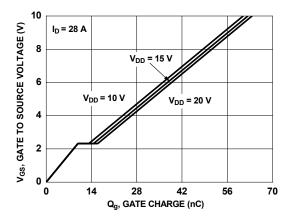


Figure 7. Gate Charge Characteristics

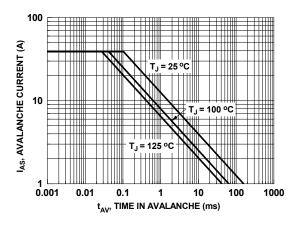


Figure 9. Unclamped Inductive Switching Capability

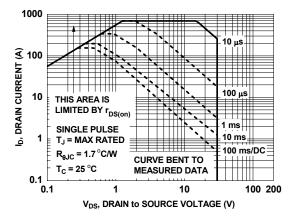


Figure 11. Forward Bias Safe Operating Area

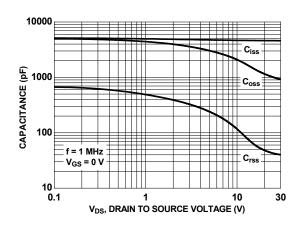


Figure 8. Capacitance vs. Drain to Source Voltage

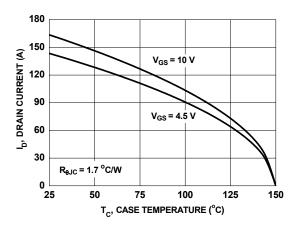


Figure 10. Maximum Continuous Drain Current vs Case Temperature

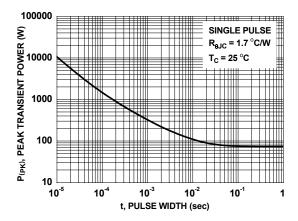


Figure 12. Single Pulse Maximum Power Dissipation

# **Typical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted.

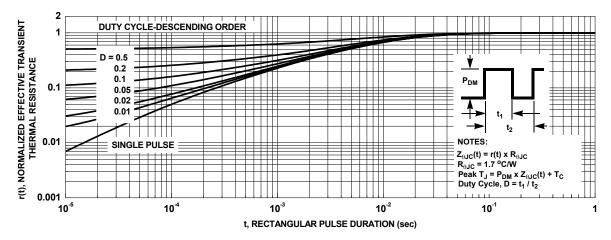


Figure 13. Junction-to-Case Transient Thermal Response Curve

# Typical Characteristics (continued)

# SyncFET<sup>TM</sup> Schottky body diode Characteristics

Fairchild's SyncFET<sup>TM</sup> process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS2D4N03S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

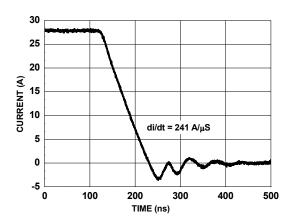


Figure 14. FDMS2D4N03S SyncFET<sup>TM</sup> Body Diode Reverse Recovery Characteristic

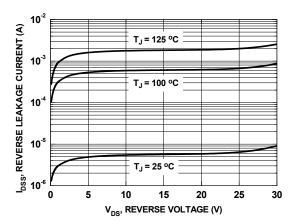
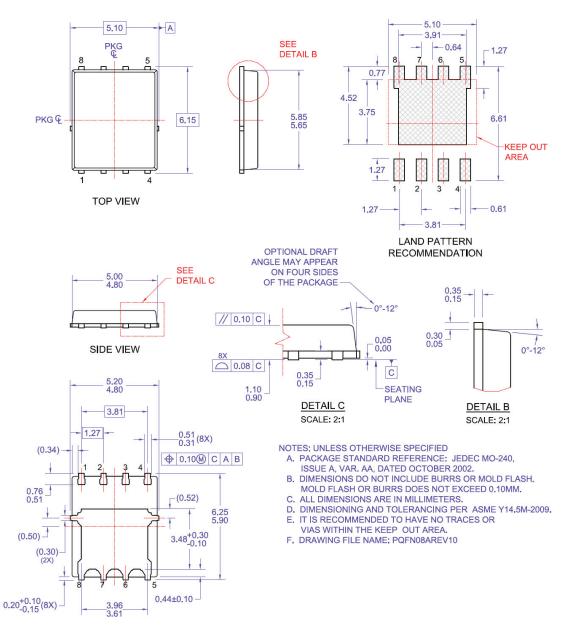


Figure 15. SyncFET<sup>TM</sup> Body Diode Reverse Leakage vs. Drain-Source Voltage

## **Dimensional Outline and Pad Layout**



**BOTTOM VIEW** 

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